# OptiMOS™-T Power-Transistor

AEC Qualified

RoHS

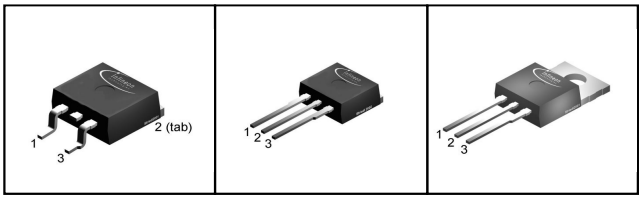
**Product Summary**

| | | |
|---|---|---|
| $V_{DS}$ | 100 | V |
| $R_{DS(on),max}$ (SMD version) | 11.3 | mΩ |
| $I_D$ | 70 | A |

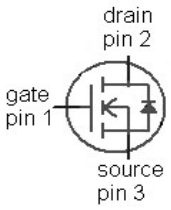
**Features**

- N-channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested

PG-TO263-3-2 | PG-TO262-3-1 | PG-TO220-3-1




| Type | Package | Marking |
|---|---|---|
| IPB70N10S3-12 | PG-TO263-3-2 | 3N1012 |
| IPI70N10S3-12 | PG-TO262-3-1 | 3N1012 |
| IPP70N10S3-12 | PG-TO220-3-1 | 3N1012 |




**Maximum ratings,** at $T_j$=25 °C, unless otherwise specified

| Parameter | Symbol | Conditions | Value | Unit |
|---|---|---|---|---|
| Continuous drain current | $I_D$ | $T_C$=25 °C, $V_{GS}$=10 V | 70 | A |
| | | $T_C$=100 °C, $V_{GS}$=10 V[2)] | 48 | |
| Pulsed drain current[1)] | $I_{D,pulse}$ | $T_C$=25 °C | 280 | |
| Avalanche energy, single pulse[1)] | $E_{AS}$ | $I_D$=35A | 410 | mJ |
| Avalanche current, single pulse | $I_{AS}$ | | 70 | A |
| Gate source voltage | $V_{GS}$ | | ±20 | V |
| Power dissipation | $P_{tot}$ | $T_C$=25 °C | 125 | W |
| Operating and storage temperature | $T_j$, $T_{stg}$ | | -55 ... +175 | °C |
| IEC climatic category; DIN IEC 68-1 | | | 55/175/56 | |

| Parameter | Symbol | Conditions | Values | | | Unit |
|---|---|---|---|---|---|---|
| | | | min. | typ. | max. | |
| **Thermal characteristics**[1] | | | | | | |
| Thermal resistance, junction - case | $R_{thJC}$ | | - | - | 1.2 | K/W |
| Thermal resistance, junction - ambient, leaded | $R_{thJA}$ | | - | - | 62 | |
| SMD version, device on PCB | $R_{thJA}$ | minimal footprint | - | - | 62 | |
| | | 6 $cm^2$ cooling area[2] | - | - | 40 | |
| **Electrical characteristics,** at $T_j$=25 °C, unless otherwise specified | | | | | | |
| **Static characteristics** | | | | | | |
| Drain-source breakdown voltage | $V_{(Br)DSS}$ | $V_{GS}$=0 V, $I_D$= 1 mA | 100 | - | - | V |
| Gate threshold voltage | $V_{GS(th)}$ | $V_{DS}$=$V_{GS}$, $I_D$=83µA | 2.0 | 3.0 | 4.0 | |
| Zero gate voltage drain current | $I_{DSS}$ | $V_{DS}$=80 V, $V_{GS}$=0 V, $T_j$=25 °C | - | 0.01 | 1 | µA |
| | | $V_{DS}$=80 V, $V_{GS}$=0 V, $T_j$=125 °C[2] | - | 0.1 | 10 | |
| Gate-source leakage current | $I_{GSS}$ | $V_{GS}$=20V, $V_{DS}$=0V | - | - | 100 | nA |
| Drain-source on-state resistance | $R_{DS(on)}$ | $V_{GS}$=10V, $I_D$=70A | - | 9.7 | 11.6 | mΩ |
| | | $V_{GS}$=10V, $I_D$=70A, SMD version | - | 9.4 | 11.3 | |

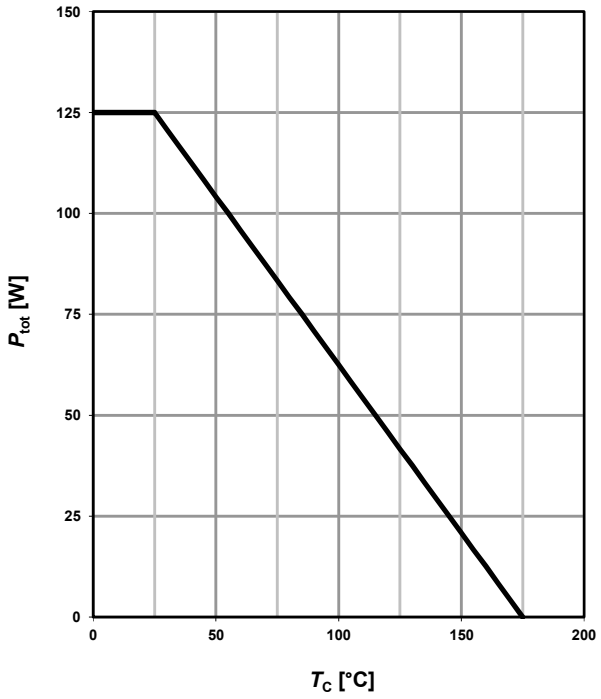
| Parameter | Symbol | Conditions | Values | | | Unit |
|---|---|---|---|---|---|---|
| | | | min. | typ. | max. | |
| **Dynamic characteristics**[1] | | | | | | |
| Input capacitance | $C_{iss}$ | $V_{GS}$=0V, $V_{DS}$=25V, $f$=1MHz | - | 3350 | 4355 | pF |
| Output capacitance | $C_{oss}$ | | - | 940 | 1222 | |
| Reverse transfer capacitance | $C_{rss}$ | | - | 105 | 158 | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD}$=20 V, $V_{GS}$=10 V, $I_D$=70 A, $R_G$=3.5 Ω | - | 17 | - | ns |
| Rise time | $t_r$ | | - | 8 | - | |
| Turn-off delay time | $t_{d(off)}$ | | - | 25 | - | |
| Fall time | $t_f$ | | - | 8 | - | |
| **Gate Charge Characteristics**[1] | | | | | | |
| Gate to source charge | $Q_{gs}$ | $V_{DD}$=80 V, $I_D$=70 A, $V_{GS}$=0 to 10 V | - | 17 | 23 | nC |
| Gate to drain charge | $Q_{gd}$ | | - | 12 | 19 | |
| Gate charge total | $Q_g$ | | - | 51 | 66 | |
| Gate plateau voltage | $V_{plateau}$ | | - | 5.5 | - | V |
| **Reverse Diode** | | | | | | |
| Diode continous forward current[1] | $I_S$ | $T_C$=25°C | - | - | 70 | A |
| Diode pulse current[1] | $I_{S,pulse}$ | | - | - | 280 | |
| Diode forward voltage | $V_{SD}$ | $V_{GS}$=0 V, $I_F$=70 A, $T_j$=25 °C | 0.6 | 1 | 1.2 | V |
| Reverse recovery time[1] | $t_{rr}$ | $V_R$=50V, $I_F$=$I_S$, d$i_F$/d$t$=100A/µs | - | 100 | - | ns |
| Reverse recovery charge[1] | $Q_{rr}$ | | - | 265 | - | nC |

[1] Defined by design. Not subject to production test.

[2] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm$^2$ (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

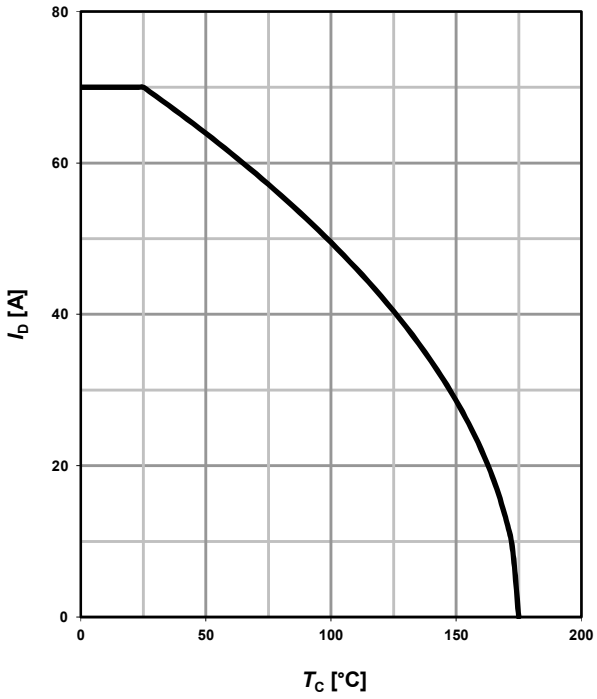
## 1 Power dissipation

$P_{tot} = f(T_C)$; $V_{GS} \geq 6$ V




## 2 Drain current

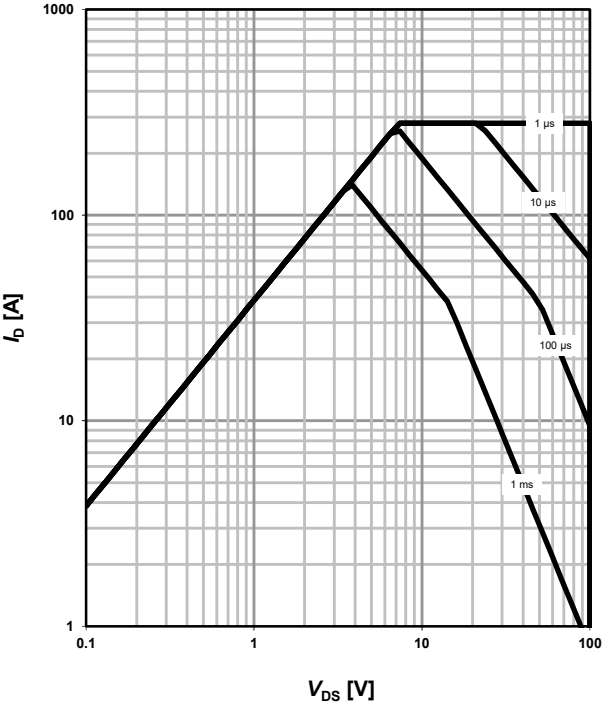
$I_D = f(T_C)$; $V_{GS} \geq 6$ V; SMD




## 3 Safe operating area

$I_D = f(V_{DS})$; $T_C = 25$ °C; $D = 0$; SMD

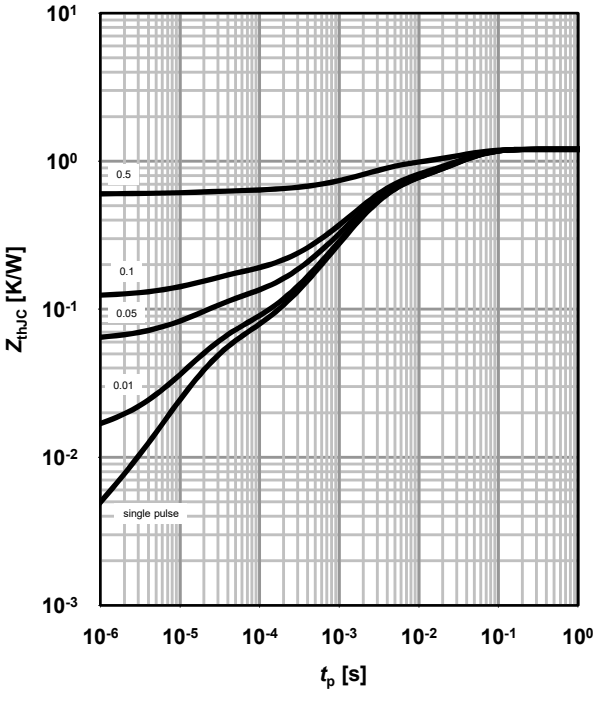
parameter: $t_p$




## 4 Max. transient thermal impedance

$Z_{thJC} = f(t_p)$

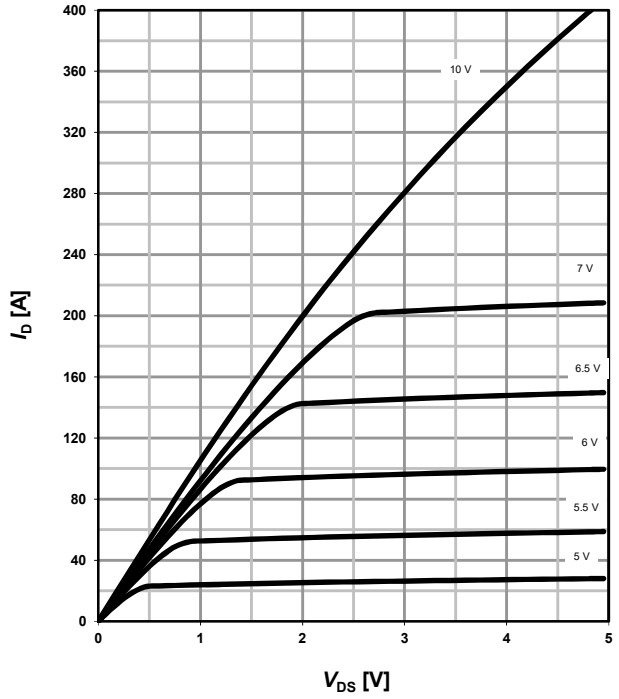
parameter: $D = t_p/T$



## 5 Typ. output characteristics

$I_D = f(V_{DS})$; $T_j = 25$ °C; SMD

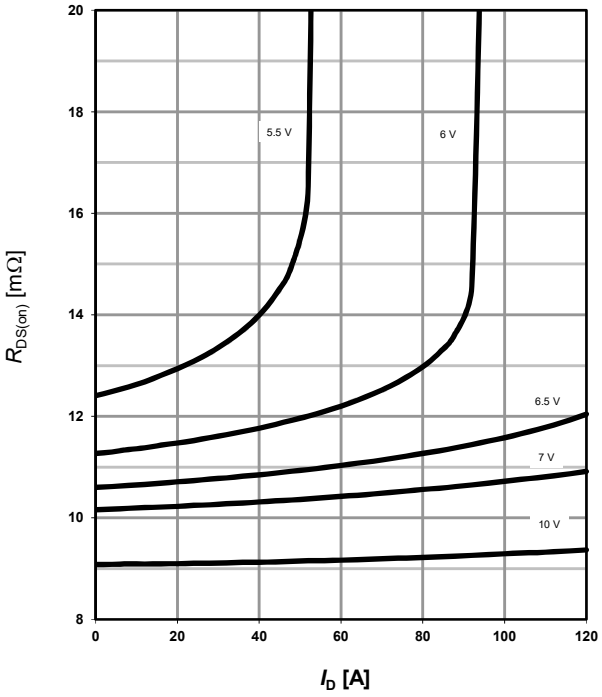
parameter: $V_{GS}$




## 6 Typ. drain-source on-state resistance

$R_{DS(on)} = f(I_D)$; $T_j = 25$ °C; SMD

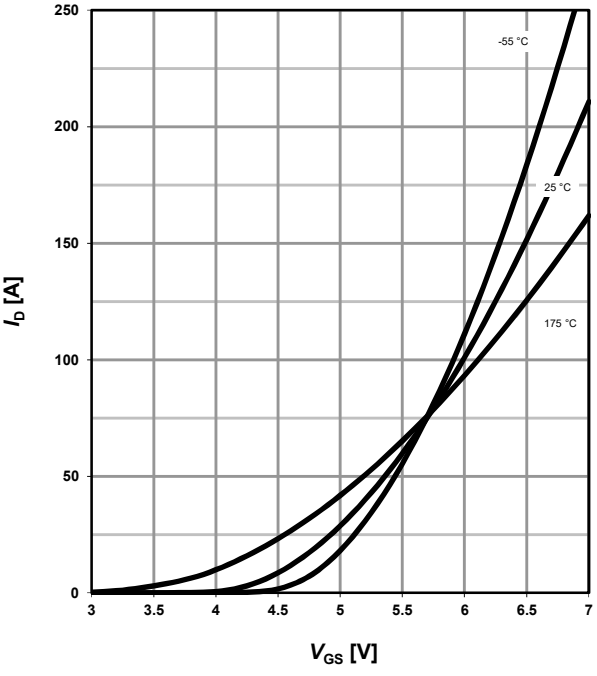
parameter: $V_{GS}$




## 7 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} = 6$V

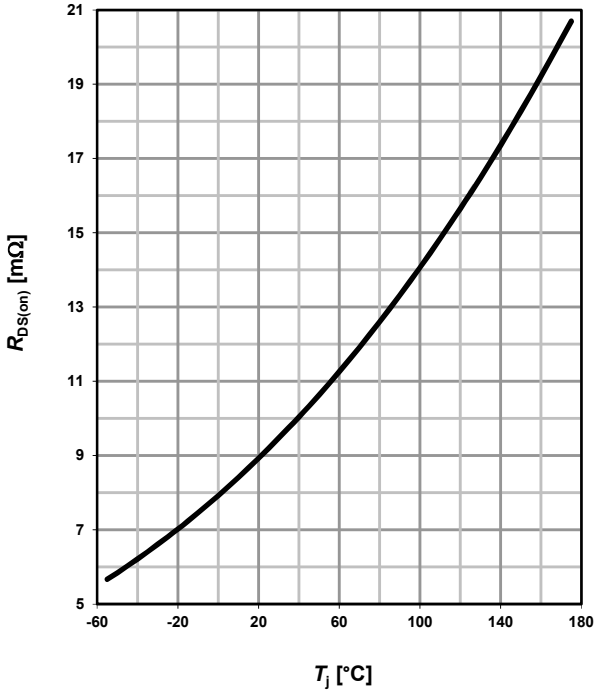
parameter: $T_j$




## 8 Typ. drain-source on-state resistance

$R_{DS(on)} = f(T_j)$; $I_D = 70$ A; $V_{GS} = 10$ V; SMD

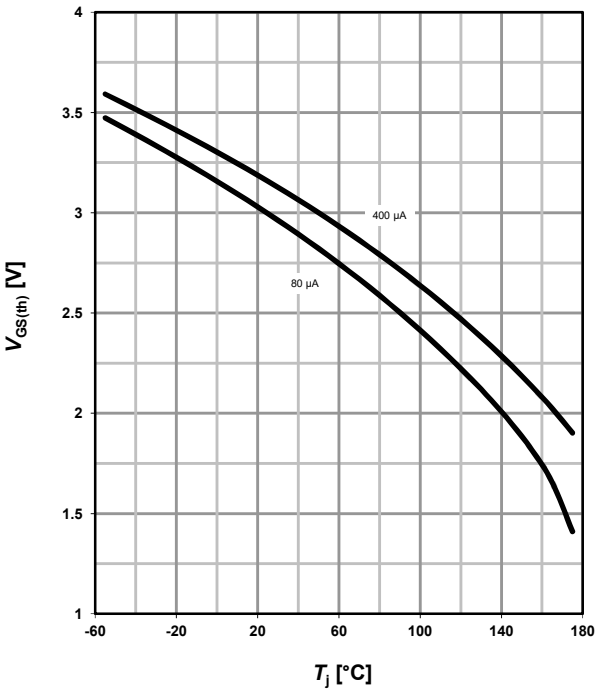
α = 0.56



## 9 Typ. gate threshold voltage

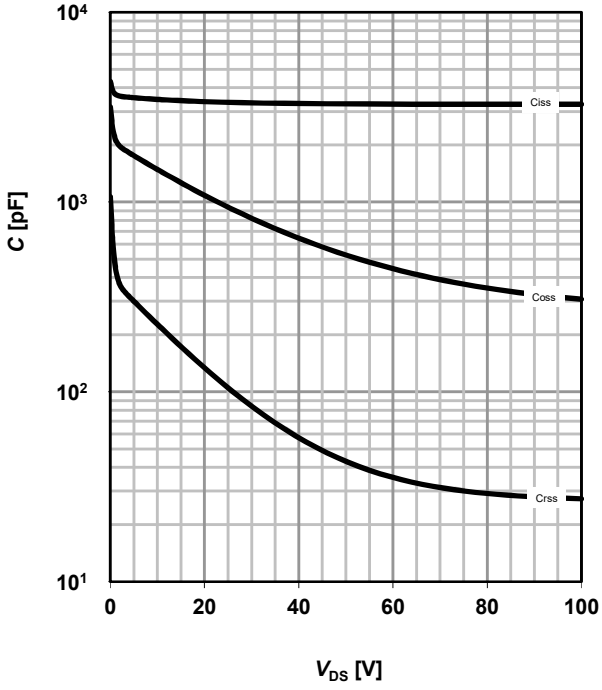
$V_{GS(th)} = f(T_j)$; $V_{GS} = V_{DS}$

parameter: $I_D$




## 10 Typ. capacitances

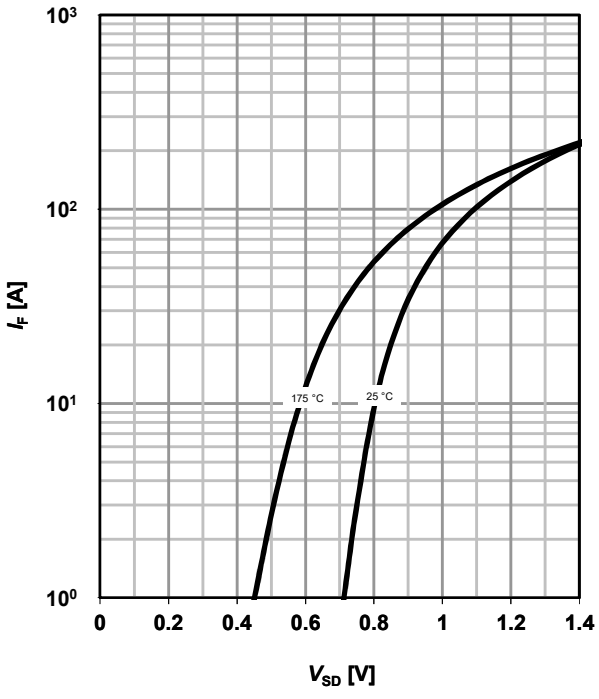
$C = f(V_{DS})$; $V_{GS} = 0$ V; $f = 1$ MHz




## 11 Typical forward diode characteristicis

$I_F = f(V_{SD})$

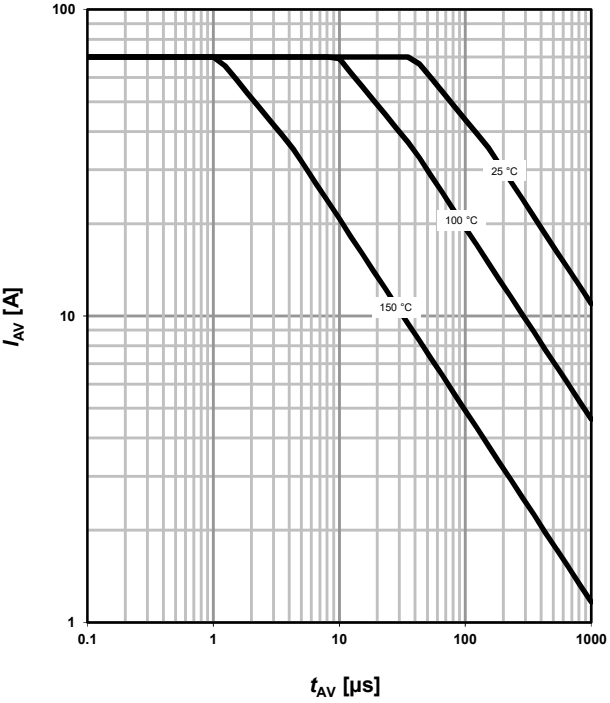
parameter: $T_j$




## 12 Typ. avalanche characteristics

$I_{AS} = f(t_{AV})$

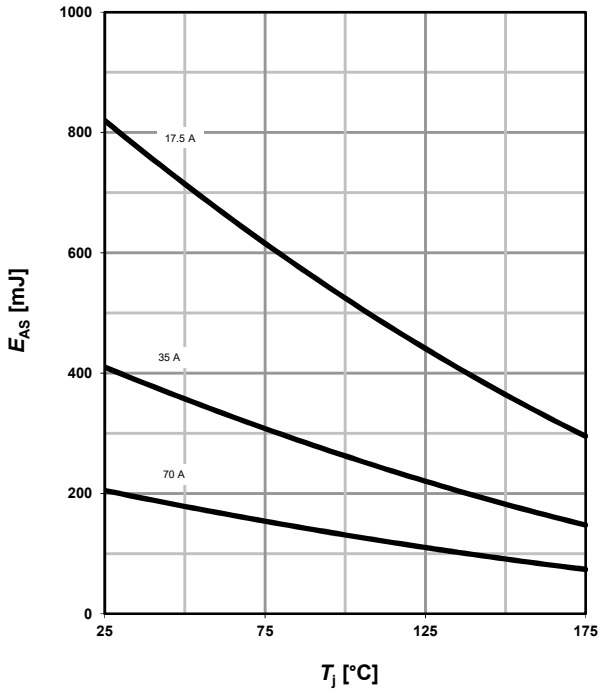
parameter: $T_{j(start)}$



## 13 Typical avalanche energy

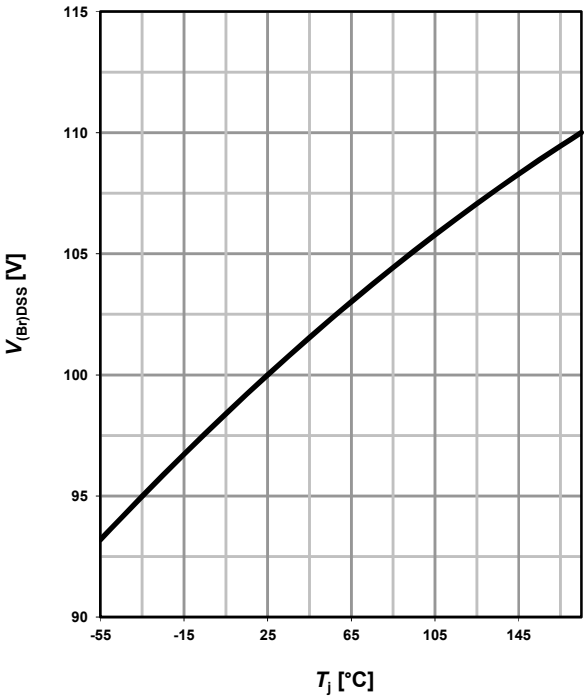
$E_{AS} = f(T_j)$

parameter: $I_D$




## 14 Typ. drain-source breakdown voltage

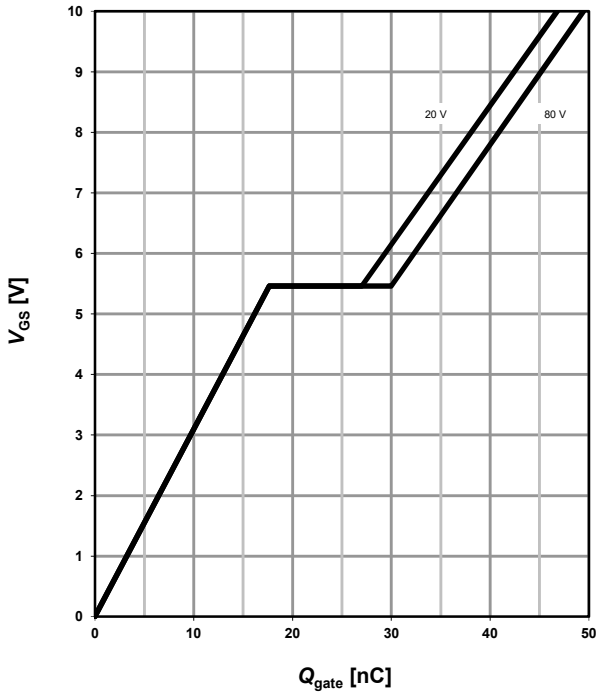
$V_{(Br)DSS} = f(T_j)$; $I_D = 1$ mA



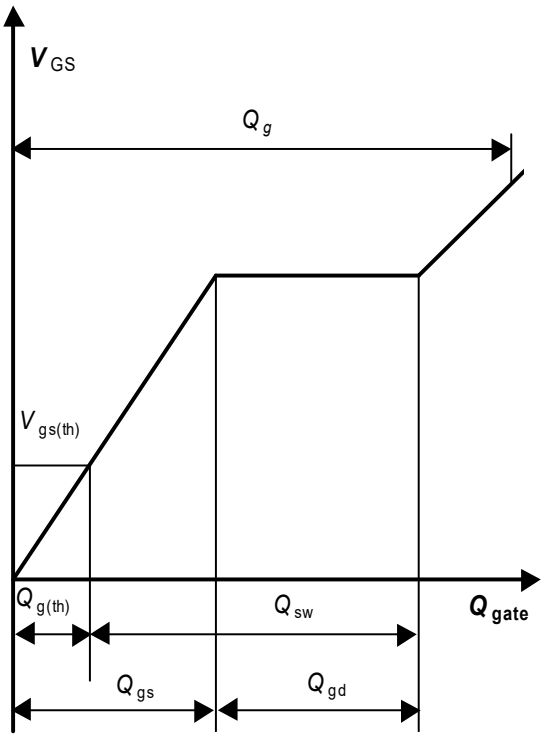

## 15 Typ. gate charge

$V_{GS} = f(Q_{gate})$; $I_D = 70$ A pulsed

parameter: $V_{DD}$




## 16 Gate charge waveforms



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Revision History

| **Version** | Date | Changes |
|---|---|---|
| Revision 1.1 | 2011-06-03 | Update of Idss |
| Revision 1.2 | 2023-06-15 | Diagram 8 Typ. drain-source on-state resistance: used α value clarified |
| Revision 1.2 | 2023-06-15 | Corrected diagram 3 safe operating area |
| Revision 1.2 | 2023-06-15 | Corrected diagram 10 typical capacitances |